



STD5N52U STF5N52U

N-channel 525 V, 1.28 Ω , 4.4 A, DPAK, TO-220FP
UltraFASTmesh™ Power MOSFET

Features

Type	V _{DSS}	R _{DS(on)} max	I _D	P _w
STD5N52U	525 V	< 1.5 Ω	4.4 A	70 W
STF5N52U	525 V	< 1.5 Ω	4.4 A	25 W

- 100% avalanche tested
- Outstanding dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very low R_{DS(on)}
- Extremely low t_{rr}

Application

- Switching applications
 - High voltage inverters specific fo LCD TV
 - Lighting full bridge topology
 - Motor control

Description

The UltraFASTmesh™ series associates all advantages of reduced on-resistance, Zener gate protection and very high dv/dt capability with an extremely enhanced fast body-drain recovery diode.

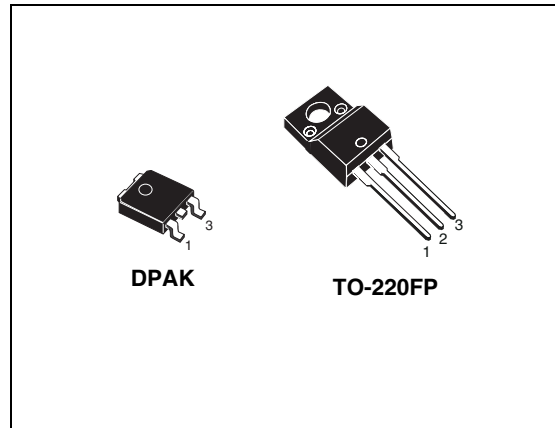


Figure 1. Internal schematic diagram

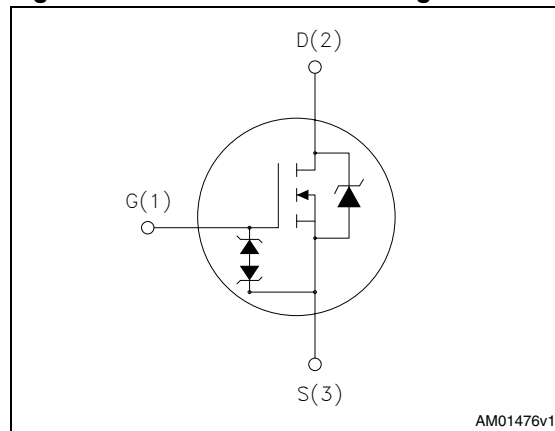


Table 1. Device summary

Order code	Marking	Package	Packaging
STD5N52U	5N52U	DPAK	Tape and reel
STF5N52U	5N52U	TO-220FP	Tube

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value		Unit
		TO-220FP	DPAK	
V_{GS}	Gate- source voltage	± 30		V
I_D	Drain current (continuous) at $T_C = 25\text{ °C}$	4.4		A
I_D	Drain current (continuous) at $T_C = 100\text{ °C}$	2.8		A
$I_{DM}^{(1)}$	Drain current (pulsed)	17.6		A
P_{TOT}	Total dissipation at $T_C = 25\text{ °C}$	25	70	W
I_{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_J max)	4.4		A
E_{AS}	Single pulse avalanche energy (starting $T_J = 25\text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50\text{ V}$)	170		mJ
$dv/dt^{(2)}$	Peak diode recovery voltage slope	20		V/ns
$V_{ESD(G-S)}$	G-S ESD (HBM $C=100\text{ pF}$; $R=1.5\text{ k}\Omega$)	2800		V
V_{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink ($t=1\text{ s}$; $T_C=25\text{ °C}$)	2500		V
T_J T_{stg}	Operating junction temperature Storage temperature	-55 to 150		°C

1. Pulse width limited by safe operating area
2. $I_{SD} \leq 4.4\text{ A}$, $di/dt \leq 400\text{ A}/\mu\text{s}$, peak $V_{DS} \leq V_{(BR)DSS}$

Table 3. Thermal data

Symbol	Parameter	Value		Unit
		TO-220FP	DPAK	
$R_{thj-case}$	Thermal resistance junction-case max	5	1.78	°C/W
$R_{thj-amb}$	Thermal resistance junction-ambient max	62.5	100	°C/W
T_J	Maximum lead temperature for soldering purpose	300		°C/W

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	525			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating, T _C = 125 °C			10 500	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			10	μA
V _{GS(th)}	Gate threshold voltage	V _{DS} = V _{GS} , I _D = 50 μA	3	3.75	4.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 2.2 A		1.28	1.5	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C _{iss}	Input capacitance	V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0	-	529	-	pF
C _{oss}	Output capacitance			71		
C _{rss}	Reverse transfer capacitance			13.4		
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 420 V, V _{GS} = 0	-	11	-	pF
R _g	Gate input resistance	f = 1 MHz open drain	-	6	-	Ω
Q _g	Total gate charge	V _{DD} = 416 V, I _D = 4.4 A, V _{GS} = 10 V (see Figure 17)	-	16.9	-	nC
Q _{gs}	Gate-source charge			4.2		
Q _{gd}	Gate-drain charge			8.4		

1. C_{oss eq} time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 260 V, I _D = 2.2 A, R _G = 4.7 Ω, V _{GS} = 10 V (see Figure 16)	-	11.4	-	ns
t _r	Rise time			13.6		
t _{d(off)}	Turn-off-delay time			23.1		
t _f	Fall time			15		

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current		-		4.4	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		17.6	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 4.4 \text{ A}$, $V_{GS} = 0$	-		1.6	V
t_{rr}	Reverse recovery time	$I_{SD} = 4.4 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$	-	55		ns
Q_{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}$	-	95		μC
I_{RRM}	Reverse recovery current	(see Figure 18)	-	3.5		A
t_{rr}	Reverse recovery time	$I_{SD} = 4.4 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$	-	120		ns
Q_{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}$, $T_J = 150 \text{ }^\circ\text{C}$	-	266		μC
I_{RRM}	Reverse recovery current	(see Figure 18)	-	4.5		A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
BV_{GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}$ (open drain)	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220FP Figure 3. Thermal impedance for TO-220FP

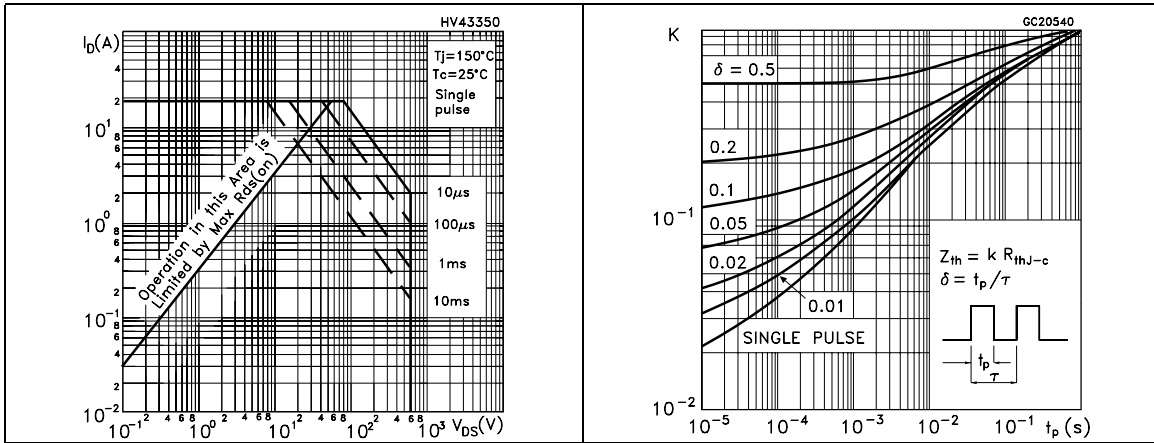


Figure 4. Safe operating area for DPAK

Figure 5. Thermal impedance for DPAK

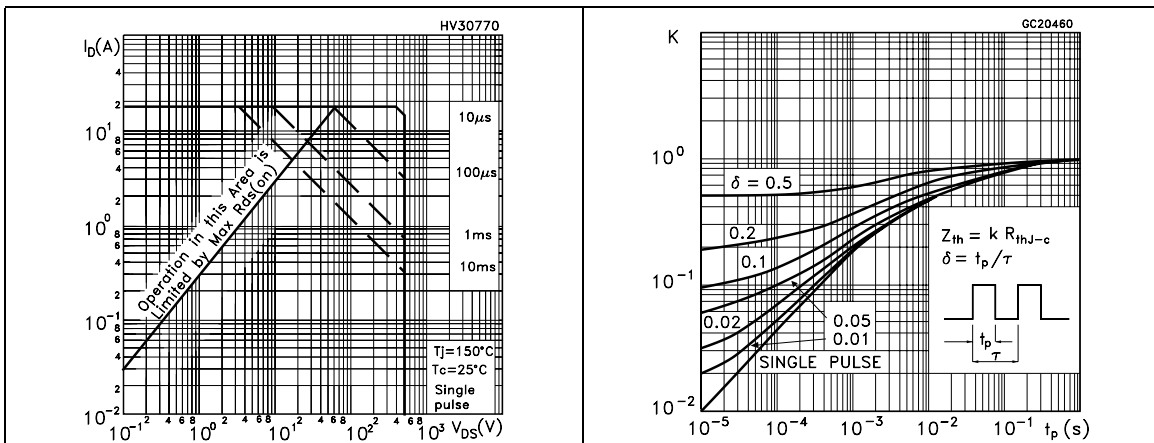


Figure 6. Output characteristics

Figure 7. Transfer characteristics

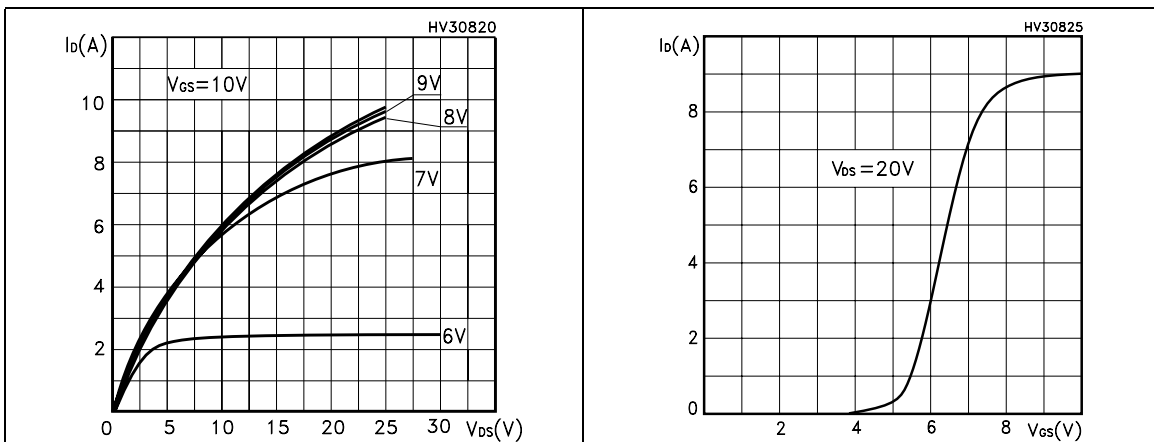


Figure 8. Normalized BV_{DSS} vs temperature Figure 9. Static drain-source on resistance

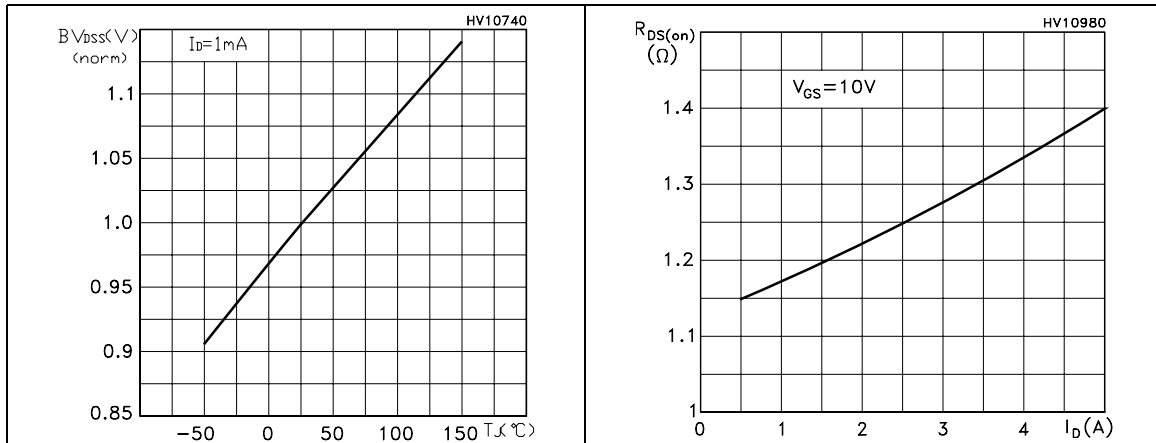


Figure 10. Gate charge vs gate-source voltage Figure 11. Capacitance variations

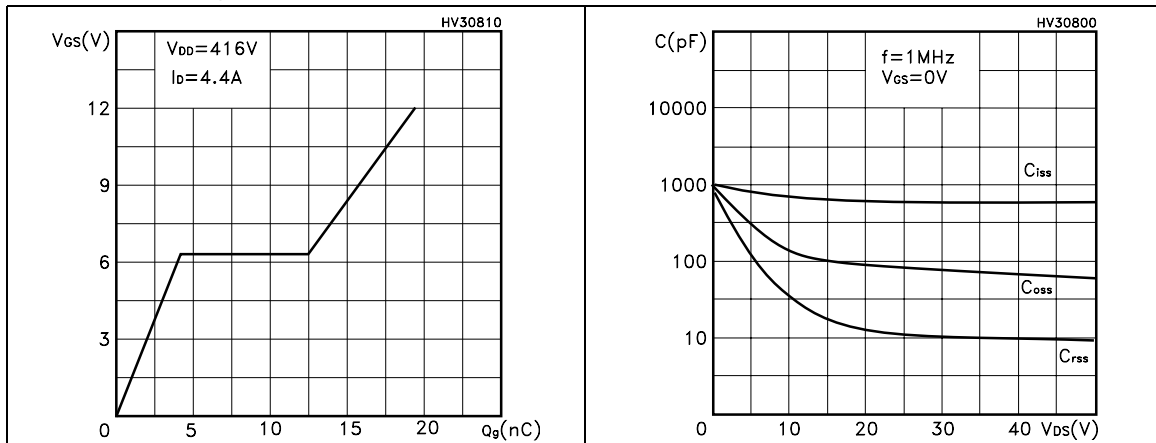


Figure 12. Normalized gate threshold voltage vs temperature Figure 13. Normalized on resistance vs temperature

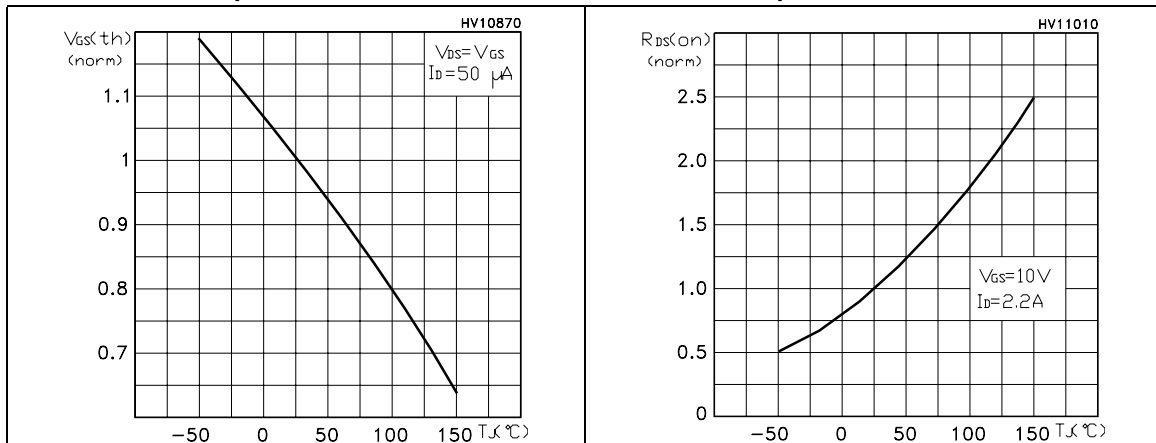


Figure 14. Source-drain diode forward characteristics

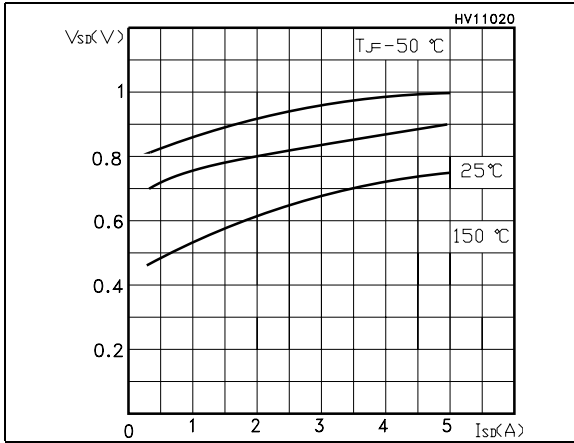
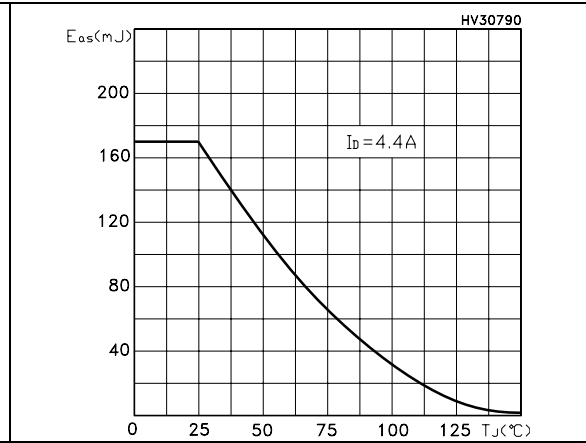


Figure 15. Maximum avalanche energy vs temperature



3 Test circuits

Figure 16. Switching times test circuit for resistive load

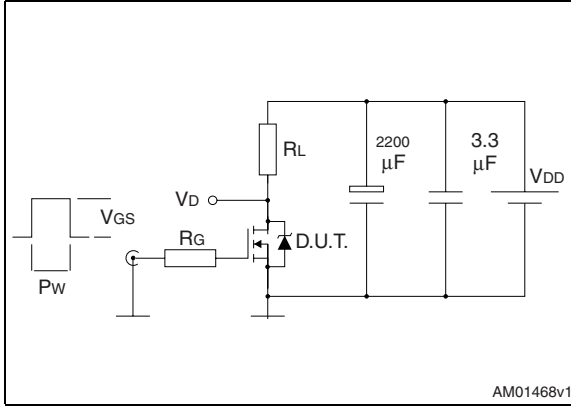


Figure 17. Gate charge test circuit

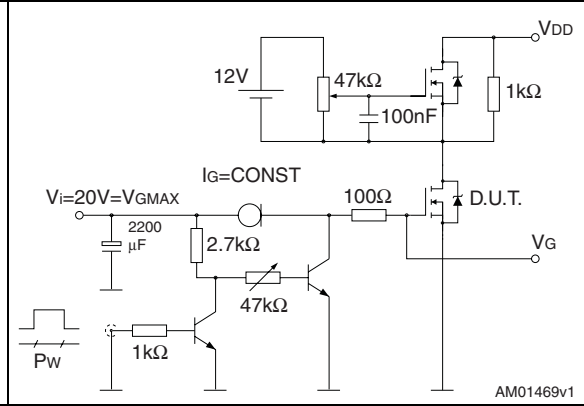


Figure 18. Test circuit for inductive load switching and diode recovery times

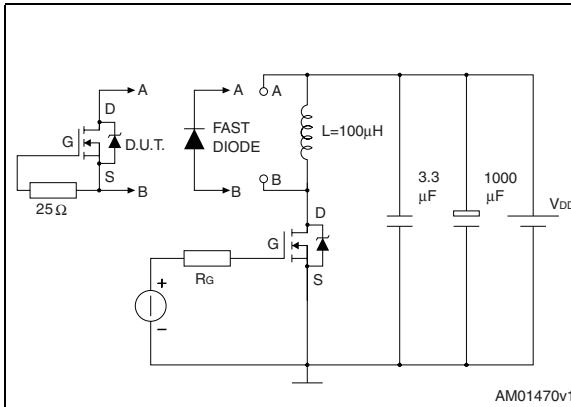


Figure 19. Unclamped inductive load test circuit

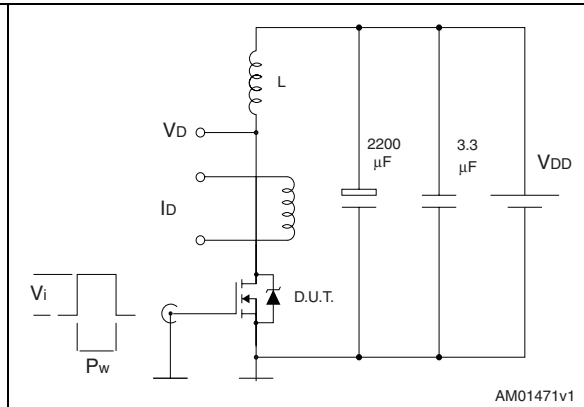


Figure 20. Unclamped inductive waveform

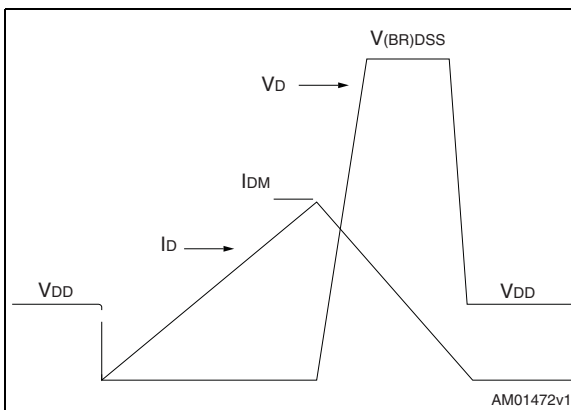
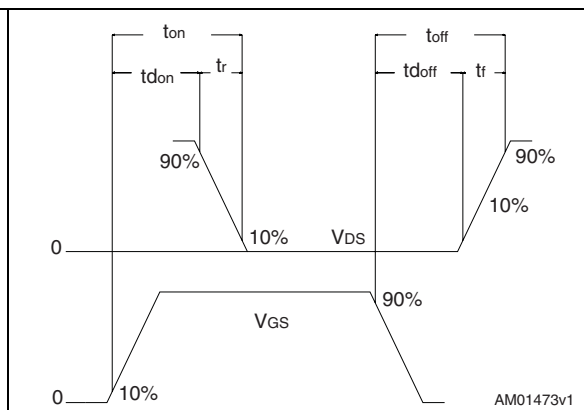


Figure 21. Switching time waveform

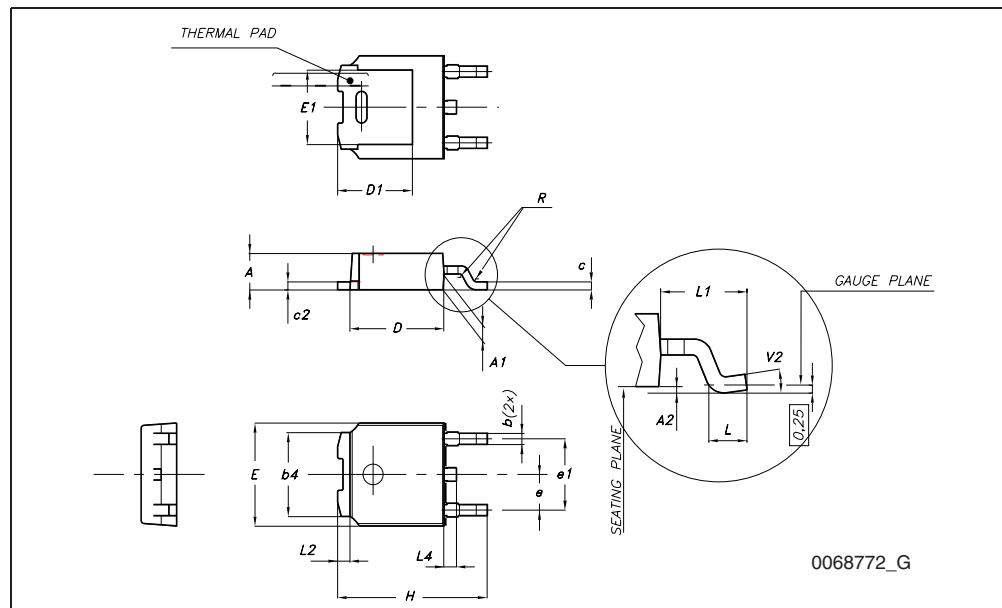


4 Package mechanical data

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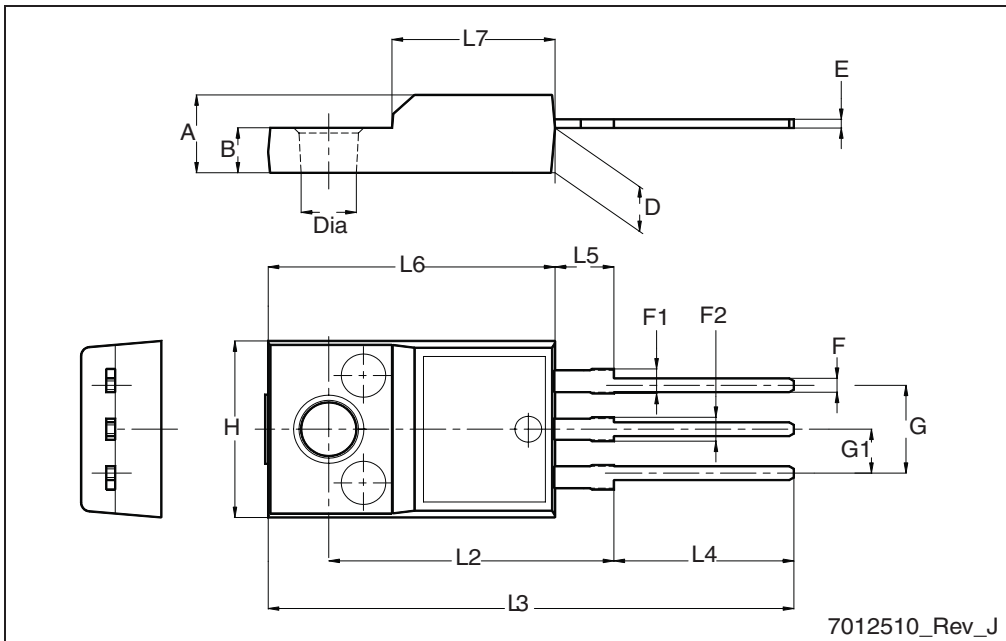
TO-252 (DPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0°		8°



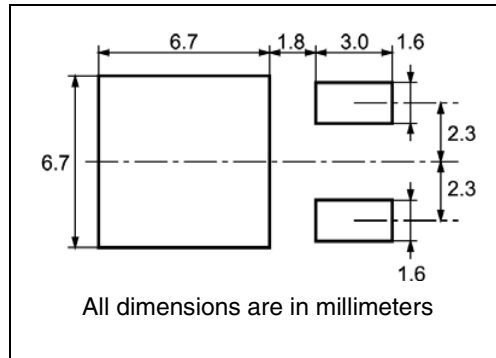
TO-220FP mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.5
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

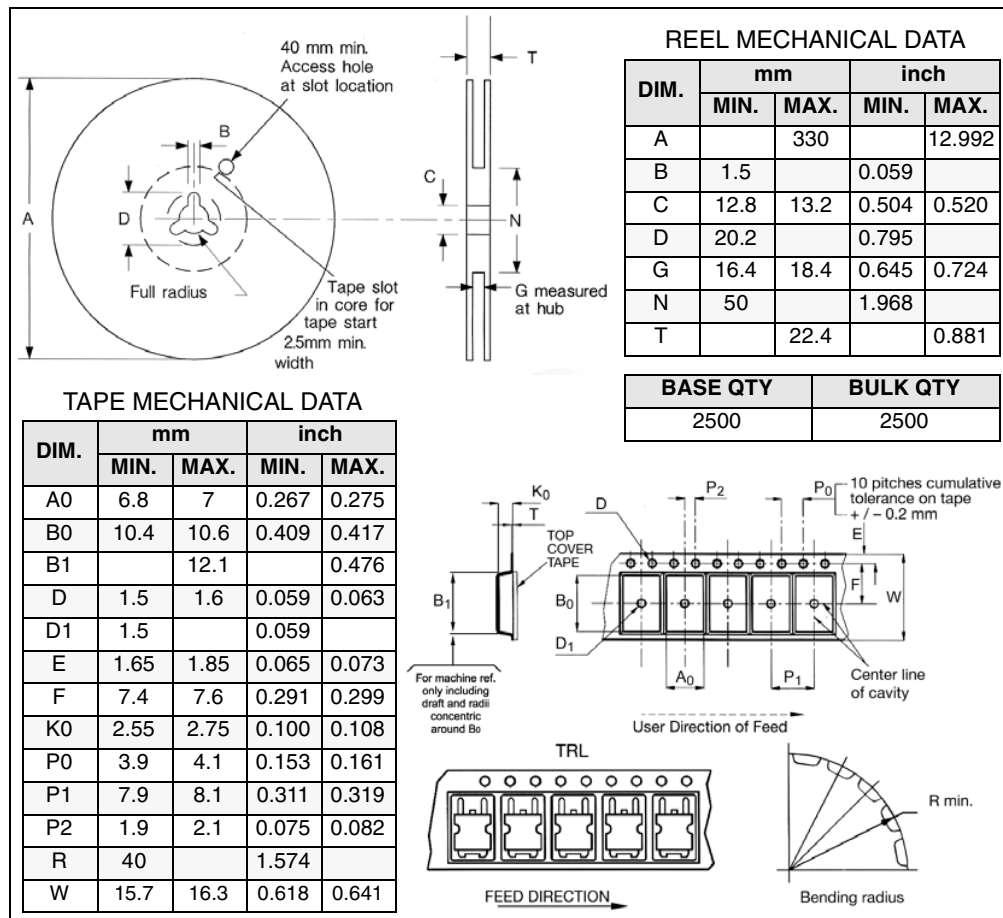


5 Packaging mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



6 Revision history

Table 9. Document revision history

Date	Revision	Changes
06-May-2009	1	First release

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